Refractive index of interdiffused AlGaAs/GaAs quantum well

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A model is developed for the polarization dependent refractive index of interdiffused AlGaAs/GaAs quantum well at room temperature for wavelengths ranging from 0.6 to 2 μm. The present model is based on a semianalytic and semiempirical method through the Kramers–Kronig transformation. The multi-quantum-well structures, including the exciton effect and above barrier gap contributions, are fully considered in this model. The distinct structures at energies of the $E_0, E_0 + \Delta_0, E_1$, and $E_2$ critical points are revealed. Moreover, the birefringence at room temperature is also analyzed in the wavelength range varying from 0.7 to 1.0 μm. The calculated refractive index results are in satisfactory agreement with the experimental measurements over the quantum well band edge, i.e., 0.8–0.9 μm. The effect of interdiffusion on the change of refractive index is discussed. The polarization dependent absorption coefficients are also calculated with all the bound excitons, and results agree well with experiments. These results are important, since refraction index in a particular wavelength region of interest, where experimental data are not available, can be determined and thus are very useful in the design of devices. © 1997 American Institute of Physics. [S0021-8979(97)00724-X]

I. INTRODUCTION

Thermal induced quantum well (QW) intermixing arouses considerable interest both from a fundamental and an application point of view. The constituent atoms in the QW, such as (Al,Ga) in the ternary AlGaAs/GaAs alloy system, interdiffused (intermixed) through the heterointerfaces, creates a graded alloy composition profile. This results in a graded nonsquare band gap along the growth axis and because the interdiffused quantum well (DFQW) confinement of the electrons and holes is also nonsquare, interesting physics arises. As the band structure has now been modified by interdiffusion, the band gap and optical properties are changed. In particular, while band gap and absorption band edge energy increase with interdiffusion, the refractive index decreases. In realization of high performance photonic devices, the interplay between the physical dimension of devices and the refractive index requires the index to be known accurately as a function of wavelength and QW dimension. For example, if impurities or vacancies are introduced selectively on the semiconductor wafer, an enhanced rate of interdiffusion is creased in the cladding region with a refractive index lower than that of sandwiched core region, thus forming a delineated waveguide. The refractive index difference is only required to be 0.003 for the AlGaAs/GaAs QW.

It is, however, rather common to use the weighted average of the refractive indexes of the well and barrier bulk materials for the refractive index of the multiple QW (MQW) multiple layers. In the case of absorption coefficient calculations, it is mostly done by using a bulk refractive index for the well layer material. These are inaccurate calculations and may give rise to erroneous predictions, if not misinterpretation of physical theories. The reason is due to very limited information from experimental measurements and theoretical calculations of both as-grown square and thermally treated QWs. The reported experimental measurement and theoretical calculations of refractive index for as-grown AlGaAs/GaAs square QWs are only available for limited wavelengths around and above the QW band edge, i.e., 0.8–0.9 μm; there are also reported calculations of refractive index in a similar wavelength range for square QW with fields and for DFQW structures in the same wavelength range. It should be noted that for applications in low loss fiber optical communications, the wavelength range of interest is above 1 μm. Therefore, there is still a requirement to determine the refractive index at wavelengths around and above 1 μm for both the as-grown square QW and the DFQW cases. However, to our knowledge, there is no comprehensive model dealing with the case of calculating the absolute refractive index (not change of refractive index) for DFQW. Therefore, there is a need to have a model on the optical parameter of DFQWs. In this article, a comprehensive model is provided for the calculation of the room temperature polarization dependent absorption coefficients and refractive index. The model for the optical transitions employs a k–p technique to the partitioned $\Gamma$, $X$, and $L$ Brillouin zones of the material and through a hybrid approach. This employs a full QW calculation for the $\Gamma$ region and the application of a 3D-like calculation for the $X$ and $L$ regions, since contributions below the barrier band-edge wavelength only affect the magnitude of $n_p$ for wavelengths above this edge. Relevant calculations and material parameters used are weighted equally between the well and barrier throughout the model, with the band structure calculation regime, in order to make the results more reliable for device modeling.

The theoretical model has been compared to experimental measurements. This is based on an Al$_{0.26}$Ga$_{0.74}$As/GaAs square QW structure with a well and barrier width both of 80 Å. It is found that the calculated spectra are in excellent agreement with the experimental data, confirming the validity of the theoretical model.
agreement with the experimental data.\textsuperscript{15} Therefore, the
theory developed here can be used as a good model for cal-
culating the absorption coefficient and refractive index of
as-grown square and interdiffused MQW structure. In Sec.
II, all the theories for modeling the interdiffused QW sub-
bands and optical parameters are shown. This is followed by
results of the calculation: first the comparison with experi-
mental results is shown; absorption coefficients, refractive
index, birefringence, and refractive index change are also
presented and discussed. Finally a conclusion is drawn.

II. MODEL FOR INTERDIFFUSED QW SUBBAND
STRUCTURE

In this model, the interdiffusion process, is based on
post-growth thermal induced interdiffusion of the Ga and Al
atoms in the AlGaAs well and AlGaAs barrier layers, respec-
tively, in the AlGaAs/GaAs MQW. The interdiffusion is
modeled here using Fick’s law with an equal and constant
interdiffusion coefficient for the two interdiffusing species.\textsuperscript{19}

The extent of the interdiffusion is characterized by a
interdiffusion length \( L_d = (D t)^{1/2} \), where \( D \) and \( t \) are the inter-
diffusion coefficient and time, respectively.\textsuperscript{20} the square of this
length represents half of the variance of the interdiffusion
distribution in a linear flow situation (i.e., \( L_d^2 = 1/2 \) variance,
and \( L_d \) = standard deviation/ \( \sqrt{2} \)). The superposition principle
is assumed for all of the layers considered in the structure,
which includes the MQW core layers and the infinitely thick
cladding layers. This is a useful and realistic model for the
interdiffusion process in the AlGaAs/GaAs material system.
The Al composition profile \( x(z) \) as a function of \( L_d \) is given by:

\[
x(z) = \frac{x_0}{2} \left[ 2 - \text{erf} \left( \frac{z - c_1}{2L_d} \right) + \text{erf} \left( \frac{z - c_2}{2L_d} \right) \right] + \sum_{i=1}^{N} \left[ \text{erf} \left( \frac{z - a_i}{2L_d} \right) - \text{erf} \left( \frac{z - b_i}{2L_d} \right) \right],
\]

where \( x_0 \) is the as-grown Al concentration in the barrier and
the cladding layer; \( N \) is the number of barriers within the
MQW core of the as-grown structure; \( \text{erf}(y) \) denotes the
error function; \( z \geq 0 \) is the growth axis of the MQW layers
where the MQW structure is positioned on the positive side;
\( a_i \) and \( b_i \) are the left and right interface positions, respec-
tively, of the \( i \)th as-grown barrier within the MQW core,
while \( c_1 \) and \( c_2 \) are at the two end positions of the
as-grown MQW core (i.e., interface between the cladding
and core layers).

The advantage of using the expression in Eq. (1) to
describe the interdiffusion induced nonsquare profile is its abili-
ty to model different MQW structures with any number of
periods, different widths, and heights of the well and barrier
layers, as well as different cladding layers, by adjusting
the terms involving \( c_1 \) and \( c_2 \). In Eq. (1), the omitted \( i = 0 \) case
represents a single QW with thick AlGaAs cladding layers,
\( i = \text{odd} \) (even) represents an even (odd) number of wells in
the MQW core with an Al concentration of \( x_0 \) in the
cladding layer. For cases which use GaAs cladding layers, such as
the resonant tunneling structures, Eq. (1) can still be used
when the constant of value 2, when terms consist of \( c_1 \) and
\( c_2 \) are dropped, and take \( N = 2 \); although this versatility is also
demonstrated in a Green’s function model.\textsuperscript{21} Eq. (1) is an
analytical expression and no numerical integration is nec-

erary. The MQW confinement profile is obtained from \( x(z) \)
by a method similar to the case of a single QW\textsuperscript{22} and is
briefly described here.

The diffused Al composition profile defined by Eq. (1) is
used to obtain the interdiffused QW parameters including
band gap, \( E_g(z) = E_g(x(z)) \), and well depth, \( \Delta E_r(L_d) = Q_r[E_g(z_1) - E_g(z_2)] \), where the subscript \( r \) denotes either
the electron in the conduction band (\( C \)), heavy or light holes
in the valence band (\( V = H \) or \( L \)), \( Q_r \) is the band offset
splitting, and \( z_1 \) and \( z_2 \) refer to the positions corresponding
to the top of the barrier and bottom of the well, respectively.

The interdiffused MQW confinement profile, \( U_r(z), \) is def-
ined as \( U_r(z) = Q_r[E_g(x(z)) - E_g(x(0))] \). The convention
here is to define zero potential both at the bottom of the
as-grown square MQW and positively up in both bands.

The QW subband edge at the zone center of \( \Gamma \) valley
symmetry can be calculated separately for electrons and
holes, using the Ben–Daniel and Duke model.\textsuperscript{23} A \( z \) position
dependent effective mass determined by the interdiffused
composition profile is used in the one-dimensional
Schrödinger-like equation, for the envelope function \( \psi_{rl}(z) \),
which is written as follows:

\[
-\frac{\hbar^2}{2} \frac{d}{dz} \left( \frac{1}{m^*_{rl}(z)} \frac{d\psi_{rl}(z)}{dz} \right) + U_r(z)\psi_{rl}(z) = E_{rl}\psi_{rl}(z),
\]

where \( l = 1,2,\ldots \) are the pure MQW subband levels for either
the electrons (\( C \)) or holes (\( V \)), respectively; these pure
sublevels \( l \) are due to the confinement effect only, where
well-to-well coupling is ignored, i.e., as if they are single
wells; \( m^*_{rl}[w(z)] \) is the carrier effective mass in the \( z \) direc-
tion which is perpendicular to the QW layers; \( E_{rl} \) is the
subband-edge energy, and the zero energy is taken to be at
the bottom of the as-grown MQW. The eigenvalue problem,
Eq. (2), is solved numerically for the entire MQW structure
using a finite difference method with the boundary condi-
tions taken to be zero at the end of a cladding layer of finite
thickness, i.e., \( \psi_{rl}(0) = \psi_{rl}(L_r) = 0 \), where \( L_r = N L_b + (N + 1) L_c + 2 L_{ox} \) (\( L_r \) is the cladding layer width); i.e., the MQW
core and cladding are embedded in a well of width \( L_f \) with
an infinitely high barrier to represent the infinitely thick
cladding layer. This method permits all the subband eigenstates
to be determined, including those due to well-to-well cou-
pling.

In order to calculate the imaginary part of the dielectric
function contributed by \( \varepsilon_{\text{bound}}(\omega) \), the band structure
dispersion along the transverse \( x-y \) direction of the quantum
well structure is required. The valence subband dispersion
for the mixing between heavy- and light-hole states (denoted
by \( V = H \) and \( V = L \), respectively) are considered here for the
transverse (parallel to QW layers) wave vector \( \|k_x\| = k_f \)
= 0, which can be solved in the neighborhood of a high
symmetry zone-center (i.e., \( k_f = 0 \)) using approximation
methods such as the one developed previously using series
expansions\textsuperscript{24} or an effective Hamiltonian.\textsuperscript{25} This approach
III. THEORETICAL MODEL FOR DIELECTRIC FUNCTIONS

The refractive index \( n_r \), the extinction coefficient \( k \), the real and imaginary parts of the dielectric function, \( \varepsilon_1 \) and \( \varepsilon_2 \), and the absorption coefficient \( \alpha \) are the fundamental optical constants and are interrelated.\(^{26}\) All these optical constants depend on the energy band structure of the semiconductor QW material. The relation between the band structure and \( \varepsilon_2 \)\(^{27}\) is:

\[
\varepsilon_2(E) = \frac{\varepsilon^2 \hbar^2}{\pi m^* E^2} \int dkM_{\varepsilon k}(k)^2 \delta(E_v(k) - E_v(k) - E),
\]

where the Dirac \( \delta \) function represents the joint spectral density of states between valence \( [E_v(k)] \) and conduction \( [E_c(k)] \) band states differing by the energy \( E = \hbar \omega \) of the incident light and \( M_{\varepsilon k}(k) \) is the momentum matrix element between the valence and conduction band states. The real part of the dielectric function \( \varepsilon_1 \) is related to the imaginary part \( \varepsilon_2 \) by the Kramers–Kronig relations:\(^{26}\)

\[
\varepsilon_1(E) - 1 = \frac{2}{\pi} \frac{PV}{\int_{0}^{E} \frac{E' \varepsilon_2(E')}{(E')^2 - E} dE'},
\]

where \( PV \) denotes the principal part of the integral is taken. Also,

\[
\varepsilon_1(\omega) = \varepsilon_1^L(\omega) + \varepsilon_1^V(\omega) + \varepsilon_0 \omega,
\]

\[
\varepsilon_2(\omega) = \varepsilon_2^L(\omega) + \varepsilon_2^V(\omega) + \varepsilon_2^B(\omega) + \varepsilon_2^P,
\]

where \( \varepsilon_1^L, \varepsilon_2^L \) denotes the contribution from the \( \Gamma \) valley; \( \varepsilon_1^V, \varepsilon_2^V \) denotes the contribution from \( L \) valley; \( \varepsilon_1^X, \varepsilon_2^X \) denotes the contribution from \( X \) valley; \( \varepsilon_2^B \) denotes the contribution from transition to \( \varepsilon_2 \); and \( \varepsilon_2^P \) denotes the contribution of indirect transitions to \( \varepsilon_2 \). In principle, with the knowledge of \( \varepsilon_1 \) and \( \varepsilon_2 \), all the other optical constants can be calculated. The refractive index, \( n_r \), and absorption coefficient, \( \alpha \), can be calculated through \( \varepsilon_1 \) and \( \varepsilon_2 \):

\[
n_r(\omega) = \frac{\varepsilon_1(\omega) + \frac{1}{2}[\varepsilon_1(\omega)]^2 + [\varepsilon_2(\omega)]^2}{c_0(\varepsilon_1(\omega) + \frac{1}{2}[\varepsilon_1(\omega)]^2 + [\varepsilon_2(\omega)]^2)^{1/2}},
\]

\[
\alpha(\omega) = \omega \varepsilon_2(\omega) / c_0(\varepsilon_1(\omega) + \frac{1}{2}[\varepsilon_1(\omega)]^2 + [\varepsilon_2(\omega)]^2)^{1/2},
\]

where \( c_0 \) is the speed of light in vacuum.

The optical constants depend ultimately on the energy band structure of AlGaAs/GaAs QW, therefore, the model to be presented is based on the energy band structure and relevant contributions of the band structure is also shown.

In the following, a theoretical model of the III-V semiconductor QW refractive index, with the effect of QW interdiffusion, will be presented. In the model, various contributions of the QW band structure at different transition energies \([E_0, E_0 + \Delta_0](\text{correspond to } \Gamma \text{ valley}), E_1, E_2 (\text{correspond to } L \text{ and } X \text{ valley, respectively})\) are considered. Also, the effects of higher energy transitions, which will take an important part in the calculation of the refractive index, will be discussed.

A. \( \Gamma \) valley

The direct edge \( E_0 \) and the spin-split levels \( E_0 + \Delta_0 \) are considered. The effect of quantum well on the energy transitions contributes most in this valley. In our model, we shall take into account this effect in the imaginary part of the dielectric function.

By considering the effect of bound state and continuum state contributed by the QW material, a simple equation summing up the imaginary parts of the different contributions is derived:

\[
\varepsilon_2^I(\omega) = \varepsilon_2^L(\omega) + \varepsilon_2^V(\omega) + \varepsilon_2^\text{com}(\omega),
\]

where \( \omega \) is the angular frequency, \( \varepsilon_2^I \) is the imaginary part of the dielectric function of the \( \Gamma \) valley, \( \varepsilon_2^L \) is the imaginary part of the dielectric function contributed by the QW 1S exciton effect, \( \varepsilon_2^V \) is the imaginary part of the dielectric function contributed by the conduction-valence band QW bound state, and \( \varepsilon_2^\text{com} \) is the imaginary part of the dielectric function contributed by weighting the AlGaAs barrier and GaAs well continuum higher energy region above the barrier energy in the multi-layered QW structure.

The bound state \( \varepsilon_2^b(\omega) \) calculation is first considered, which is based on the direct interband transitions around the absorption edge in the \( \Gamma \) valley, and an additional factor to take account of the polarization, \( \varepsilon_2 \) is expressed as:

\[
\varepsilon_2^b(\omega) = \varepsilon_2^B(\omega) = \frac{\varepsilon^2 M_{L0}^{\rho}}{\pi \varepsilon_0 m^* \omega^2 L_z} \sum_{l,l'} \int dk|\langle \psi_C l | \psi_{VL} l' \rangle|^2 \frac{1}{\hbar \omega},
\]

where \( \varepsilon_0 \) is the permittivity of free space; \( e \) and \( m_0 \) are the electron charge and rest mass respectively; \( M_{L0}^{\rho} = m_{0}^{3/2} h \), and \( P \) is given by Kane’s model; \( \rho \) is the polarization factor; \( \mathcal{Z} \) is the Lorentzian broadening factor with half-width-half maximum \( \Gamma_{V} \); the summation in Eq. (10) is over all the subband and mini-subband bound and some low energy region continuum states in both bands.

The exciton effect can be obtained by solving Eq. (2). The 1S bound exciton wave function is determined by a perturbative-variational method,\(^{28,29}\) using the separate electron and hole bound states at \( k_v = 0 \) as the trial functions. The imaginary part of the dielectric function contributed by the 1S exciton effect \( [\varepsilon_2^{exc}(\omega)] \) is derived by the density matrix approach at the subband edge without the influence of band mixing, and is given below:

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\[ \epsilon_{2}^{\text{ex}}(\omega) = \frac{e^2 M_{0} b_{0}^{\rho} L_{b}^{2}}{e_{0} \hbar m_{b}^{\rho} \omega L_{z}} \langle \psi_{\text{C1}} | \psi_{\text{V1}} \rangle^{2} \times |\psi_{1}(k=0)|^{2} \mathcal{S}(E_{\text{exc}} - \omega), \]

where

\[ \langle \psi_{\text{C1}} | \psi_{\text{V1}} \rangle = \int_{-Z_{b}}^{Z_{b}} \psi_{\text{C1}}(z) \psi_{\text{V1}}(z) dz, \]

\[ \epsilon_{0}, e, m_{0}, m_{b}, b_{0}, k, \mathcal{S}, \] and \( L_{z} \) are defined as in Eq. (10). \( E_{\text{exc}} \) is exciton transition energy; \( \psi_{1}, \psi_{e}, \) and \( \psi_{h} \) are the envelope wave functions for the electrons, the hole, and the exciton, respectively; \( \rho \) is the polarization factor at the band edge where \( \rho_{\text{TE}} = 3/2 \) (for heavy hole), \( 1/2 \) (light hole), and \( \rho_{\text{TM}} = 0 \) (heavy hole), \( 2 \) (light hole).

In the calculation of \( \epsilon_{2}^{\text{con}}(\omega) \), we have considered only the lowest direct gaps, \( E_{0} \) and \( E_{0} + \Delta_{0} \) for \( \omega \) at continuum energy. They are of the three-dimensional \( M_{0} \)-type critical points.\(^{30,31} \) Also, parabolic bands are assumed. The expression of \( \epsilon_{2}^{\text{con}}(\omega) \) is given below:

\[ \epsilon_{2}^{\text{con}}(\omega) = \left( \frac{2 \sqrt{2}(m_{0}^{\rho} \hbar^{2})}{\omega_{0} \omega} \right)^{1/2} \times H(\chi_{0} - 1) + \frac{1}{2}(\hbar \omega - E_{0})^{1/2} \times H(\chi_{0} - 1), \]

where \( \chi_{0} = \hbar \omega(0), \chi_{0} = \hbar \omega(E_{0} + \Delta_{0}), \) and \( H(y) \) is the Heaviside unit step function, \( m_{0}^{\rho} \) is the combined density-of-states mass.

In the calculation of the as-grown square quantum well, the \( \epsilon_{2}^{\text{con}}(\omega) \) is calculated by weighting the barrier and well regions together in a ratio of well width \( (L_{z}) \) to barrier width \( (L_{b}) \):

\[ \epsilon_{2}^{\text{con}}(\omega) = \frac{1}{L_{z} + L_{b}} \left[ L_{z} \epsilon_{2}^{\text{con}}(\omega) + L_{b} \epsilon_{2}^{\text{con}}(\omega) \right]. \]

For the case of interdiffused QWs, each well and barrier are divided into a total of \( n \) subintervals, for each subinterval having a constant aluminium concentration, \( x \). In our model for AlGaAs/GaAs MQW structure, \( n \) has been chosen to 20, and the width of each of the subintervals is fixed to 1 nm. \( \epsilon_{2}^{\text{con}}(\omega, x) \) at each subinterval \( \{ \epsilon_{2}^{\text{con}}(\omega) \} \), is calculated according to the varying Al distribution concentration diffusion profile. The barrier layers \( \epsilon_{2}^{\text{con}} \) are then weighted with the well layer \( \epsilon_{2}^{\text{con}} \) evenly:

\[ \epsilon_{2}^{\text{con}}(\omega) = \frac{1}{\sum_{i=1}^{n} \epsilon_{2}^{\text{con}}(\omega)} \]

where \( n \) is the total number of subintervals consist of the well and barrier.

The real part of the dielectric function, \( \epsilon_{1}(\omega) \), is determined using the Kramers–Kronig transformation of \( \epsilon_{2}^{\text{con}}(\omega) \), and is given by

\[ \epsilon_{1}(\omega) = 1 + \frac{1}{\pi} \int_{0}^{\infty} \frac{\epsilon_{2}(\omega')}{\omega' - \omega} d\omega', \]

where the second integral is a series of subdivided integrals in which the subintegration limits \( \omega' \) do not coincide with the \( \omega \) of interest, in order to permit the evaluation of the Cauchy integral numerically. Although the real part of the dielectric function, \( \epsilon_{1}(\omega) \), is not in an analytic form, we can still calculate it through numerical means.

For the Kramers–Kronig transformation of \( \epsilon_{2}^{\text{con}}(E) \), as we cannot obtain the analytical form for \( \epsilon_{1}(E) \), only numerical integration has been performed. As integration from zero to infinity is required in the integration of the transformation, and it is impractical numerically, we employed an expression at the tail of the transition which is similar to the function of \( \epsilon_{2}^{\text{con}}(E) \). We let the function be:

\[ \Omega(E) = A_{p} E^{-1/2} + B_{p}, \]

where \( A_{p} \) and \( B_{p} \) are constants which can be determined by fitting to the value of \( \epsilon_{2}^{\text{con}}(E) \) at 25 and 30 eV. The tail part of \( \epsilon_{2}^{\text{con}}(E) \) is then substituted by \( \Omega(E) \). The Kramers–Kronig transformation can now be readily performed:

\[ \epsilon_{1}^{\text{c}}(E)_{\text{tail}} = 1 - \frac{2}{p} PV \int_{30}^{E_{c}} \Omega(E')^{-1} E' dE', \]

where \( PV \) implies the principle part of the integral is taken. A relation is then obtained:

\[ \epsilon_{1}^{\text{c}}(E) = \epsilon_{1}^{\text{c}}(E \leq 30 \text{ eV})_{\text{edge}} + \epsilon_{1}^{\text{c}}(E)_{\text{tail}}. \]

By using the function \( \Omega(E) \) to model the tail part of the \( \epsilon_{1}^{\text{c}} \) spectrum, the entire spectrum is used for performing the Kramers–Kronig transformation. Therefore, \( \epsilon_{1}^{\text{c}} \) can be calculated accurately. We have worked out the values of \( A_{p} \) and \( B_{p} \) for the interdiffused MQW with \( L_{z} = L_{b} = 100 \text{ Å} \) and 0 \( \leq L_{d} \leq 100 \text{ Å} \) for references, and they are listed in Table I.

### Table I. Fitting parameters for Al$_{0.3}$Ga$_{0.7}$As/GaAsMQW $\epsilon^{\text{con}}$ part.

<table>
<thead>
<tr>
<th>( L_{d} ) (Å)</th>
<th>( A_{p}(\text{eV}^{1/2}) )</th>
<th>( B_{p}(\text{eV}^{1/2}) )</th>
</tr>
</thead>
<tbody>
<tr>
<td>0</td>
<td>0.864005541</td>
<td>-0.107955208</td>
</tr>
<tr>
<td>20</td>
<td>0.823818035</td>
<td>-0.100276807</td>
</tr>
<tr>
<td>40</td>
<td>0.864005541</td>
<td>-0.108305308</td>
</tr>
<tr>
<td>60</td>
<td>0.843908919</td>
<td>-0.105686583</td>
</tr>
<tr>
<td>100</td>
<td>0.843908917</td>
<td>-0.105686583</td>
</tr>
</tbody>
</table>

**B. L regions**

We assume that the quantum well effect can be neglected in this region. Band structure calculations indicated that the \( E_{1} \) and \( E_{1} + \Delta_{1} \) transitions take place along the \( \langle 111 \rangle \) directions or at \( L \) points in the Brillouin zone. These critical points are of the \( M_{1} \) type. The longitudinal effective mass, nevertheless, is much larger than its transverse counterparts and one can treat these critical points as two-dimensional.
damped harmonic oscillator. The expression is given calculated as shown in the beginning of this section.

\[ e_1^c(\omega) = -B_1\chi_1^{-2}\ln(1 - \chi_1^2), \] (20)

\[ e_2^c(\omega) = \pi B_1\chi_1^{-2}H(\chi_1 - 1), \] (21)

where \( \chi_1 = \hbar \omega/E_1 \) and \( B_1 \) is a strength parameter. The weighting method mentioned in the \( \Gamma \) valley is applied to Eqs. (20) and (21).

C. \( X \) regions

The transition in this region is usually labeled as \( E_2 \). As the \( E_2 \) transition does not correspond to a single, well-defined critical point, its characteristics is more complicated for analysis. It has been suggested to be due to the transitions at the \( \Gamma \) point in the Brillouin zone or to transitions at the \( X \) point or maybe both. More likely, there are several transitions involving both \( M_1 \) and \( M_2 \) type critical points which combine to form a peak in the joint density of states. We model the contributions of the feature labeled \( E_2 \) as a damped harmonic oscillator. The expression is given below: \(^{31}\)

\[ e_1^c(\omega) = C(1 - \chi_2^2)^2/[1 - \chi_2^2]^2 + \chi_2^2 \gamma^2], \] (22)

\[ e_2^c(\omega) = C\chi_2 \gamma/[1 - \chi_2^2]^2 + \chi_2^2 \gamma^2], \] (23)

where \( \chi_2 = \hbar \omega/E_2, C \) is a strength parameter, \( \gamma \) is the damping factor, and \( E_2 \) is the transition energy. The weighting method mentioned in the \( \Gamma \) valley is applied in the \( X \) regions for Eqs. (22) and (23).

D. Indirect-gap transitions

The contribution from indirect-gap transition, \( E_g^{ID} \), is taken into account. The indirect transitions from the \( x \) region conduction edge via a phonon to the \( \Gamma \) region valence edge are weak but still appreciable at room temperature. Using a perturbation calculation, and consideration of higher energy cutoff, \( E_c \), the expression for the contribution is: \(^{31}\)

\[ e_2^{ID}(\omega) = -\frac{D}{(\hbar \omega^2)^2}(\hbar \omega - E_g^{ID} + \hbar \omega q)^2H(1 - \chi_{g})H(1 - \chi_{c}), \] (24)

where \( \chi_{g} = (E_g^{ID} - \hbar \omega q)/\hbar \omega \), \( \chi_{c} = \hbar \omega/E_c \), and \( \hbar \omega q \) is the phonon energy. The cutoff energy is set to \( E_1 \).

E. Other transitions

Higher energy transitions also make contributions to the dielectric function. However, the contributions should vary weakly with photon energy. Therefore, we model the effects of all of these transitions as a single, real, additive constant \( \varepsilon_\infty \), which is not the true high frequency dielectric constant of \( \text{Al}_{x}\text{Ga}_{1-x}\text{As/GaAs} \), but simulates the effects of the higher energy transition.

All the real parts of the dielectric functions from \( \Gamma \), \( L \), and \( X \) regions, and higher energy transitions are summed to obtain the real part of the total dielectric function, \( \varepsilon_1 \) and \( \varepsilon_2 \). The refractive index and the absorption coefficient are then calculated as shown in the beginning of this section.

### IV. RESULTS AND DISCUSSION

Based on the above theoretical model, the TE and TM polarized refractive index of \( \text{Al}_{x}\text{Ga}_{1-x}\text{As/GaAs} \) MQW with well width equal to 80 Å is calculated at room temperature (300 K) according to parameters listed in Table II and its result is presented in Fig. 1 for wavelengths ranging from \( \lambda = 0.74 \mu \text{m} \) to 1.0 \( \mu \text{m} \). The room temperature (295 K) experimental result \(^{15}\) of the corresponding refractive index is also shown. The refractive index spectra at the exciton edge rises with decreasing wavelength. For the TE spectra, the refractive index reaches a heavy hole exciton peak at 0.845 \( \mu \text{m} \) and followed by a much smaller amplitude resonance due to the light hole. For the TM spectra, the refractive index reaches a single peak resonance due to the light hole exciton edge and no heavy hole resonance is found. It can be seen that the theoretical results are in satisfactory agreement with the experimental measurements. Although this agreement is only valid for the range from 0.84...

![FIG. 1. Comparison of calculated TE and TM polarization refractive index spectra to experimental results of \( \text{Al}_{x}\text{Ga}_{1-x}\text{As/GaAs} \) QW (\( L_c = 80 \text{ Å}; L_d = 0 \text{ Å} \)).](image)
to 0.88 \mu m, longer wavelength predictions of the refractive index should be a reliable source of reference for using in materials and devices applications.

The Al_{0.3}Ga_{0.7}As/GaAs QW structure with an as-grown well width of \( L_z = 100 \text{Å} \) is now analyzed here. This is a common structure used in both waveguides and optical modulators. The theoretical results of the room temperature (300 K) TE and TM polarized refractive index determined from Eq. (9) for \( L_d \) values of 0, 20, 40, 60, and 100 Å in the wavelength range of interest (0.6–1.6 \mu m) are presented in Fig. 2. Figure 2(a) shows the TE polarized refractive index spectra, for different values of the diffusion length, rise from the longer wavelengths of the spectra. As the wavelength decreases, the refractive index spectra reaches a heavy hole (HH) exciton resonance and followed by a much smaller light hole (LH) resonance peak, for the square quantum well case, at 0.853 \mu m. The HH peak positions of the spectra are located at 0.853 \mu m (\( L_d = 0 \)), 0.814 \mu m (\( L_d = 20 \text{Å} \)), 0.765 \mu m (\( L_d = 40 \text{Å} \)), 0.738 \mu m (\( L_d = 60 \text{Å} \)), and 0.712 \mu m (\( L_d = 100 \text{Å} \)). The QW barrier band gap in the present structure is \( \approx 1.83 \text{eV} \) (\( \lambda = 0.68 \mu m \)). The fine structure below the barrier edge is due to the contribution from different bound state transitions in the quantum well. The primary peak (corresponding to band-edge fundamental transition) signifies a similar dispersion which corresponds to the \( E_0 \) edge of the bulk \( \Gamma \) valley. The room temperature bulk GaAs spectrum is also shown as a reference.

In the TE case shown in Fig. 2(a) the primary peak magnitude initially decreases with increasing \( L_d \) up to 20 Å and then increases slightly as \( L_d \) reaches 40 Å. The spectrum, as interdiffusion proceeds, shifts to shorter wavelengths and to a lower refractive index. This feature is a direct consequence of the fact that QW band gap increases with interdiffusion and refractive index is inversely proportional to the band gap. The more interesting property, as a result of interdiffusion, is the crossing of the spectra in the region around the exciton band edge. For wavelengths longer than this edge, the refractive index is monotonically behaved. For wavelength shorter that the edge, the behavior is somewhat complicated. If a device is designed in this region, extreme care must be taken. The spectra rise at wavelengths below 0.6 \mu m when they reach the dispersion edges of the \( L \) and \( X \) valley.

We have also calculated the TM polarization refractive index in the same wavelength range and they are shown in Fig. 2(b). Many features are similar to the TE case. The refractive index spectra reaches a single resonance peak, for the square quantum well case, at 0.844 \mu m. The peak position of the other spectra for the different values of diffusion length are 0.807, 0.758, 0.736, and 0.708 \mu m for \( L_d = 20, 40, 60, \) and 100 Å, respectively. These peaks are due to the exciton edge of the light holes. Sharper and higher peaks appear in the TM polarization, as compared to the corresponding ones in the TE polarization, and are due to a higher absorption peak for the light hole exciton.\(^{22}\) Also, as in the case of TE polarization, the primary peak signifies a similar dispersion which corresponds to the \( E_0 \) edge of the bulk \( \Gamma \) valley.

We have plotted out the refractive index change (\( \Delta n_r \)) due to interdiffusion, as shown in Fig. 3. This \( \Delta n_r \) is defined as \( n_r(L_d \neq 0) - n_r(L_d = 0) \) at \( \lambda = 0.88 \mu m \). The change is almost linear with respect to the diffusion length up to \( L_d = 40 \text{Å} \), and comes to a saturation after \( L_d \) reaches beyond 100 Å (in which case \( L_d \gg L_z \)). The trend is applicable to both TE and TM and \( \Delta n_r \) can reach a maximum of 0.1 for \( L_d = 100 \text{Å} \). For longer diffusion lengths, the polarization dependence of refractive index is less significant than the shorter diffusion lengths, as the quantum well effect ceases with diffusion length.

The polarization dependency of the refractive index can be characterized by the birefringence (\( B = n_{r\text{TE}} - n_{r\text{TM}} \)) of the interdiffused Al_{0.3}Ga_{0.7}As/GaAs quantum wells. As clearly seen from Fig. 4 for difference diffusion lengths, the large birefringence only appears in the wavelengths ranging between the band edge of Al_{0.3}Ga_{0.7}As (0.7 \mu m) and GaAs (0.87 \mu m), where the bound states of the quantum well are situated, as the bulk GaAs and AlGaAs are not themselves a birefringent material. Outside this range the birefringence of the quantum well is small (with a maximum birefringence \( \approx 0.003 \)).

For wavelengths beyond the quantum well band edge, \( B > 0 \) for the as-grown quantum well (\( L_d = 0 \)) and, as \( L_d \) increases, \( B \) reduces to zero and then becomes negative.
(\(L_d = 20\, \text{\AA}\)) before reducing to zero again (\(L_d = 40\) and 60 \(\text{\AA}\)). The refractive index at these long wavelengths is dominated by the HH band edge and LH band edge for the TE and TM polarizations, respectively. In the \(L_d = 0\) case, as the wavelength decreases from 1 \(\mu\text{m}\), \(B\) remains positive until \(\lambda \approx 0.85\, \mu\text{m}\) and then turns negative (due to TE polarization refractive index crossing under the TM polarized refractive index around its exciton peak, see Fig. 1), since the TM polarization refractive index peak always shifts to the left because of the LH resonance. For wavelengths around exciton band edges, the birefringence is large and reduces in magnitude and shifts to shorter wavelengths, as interdiffusion increases.

The absorption coefficient spectrum at room temperature for the TE case is shown in Fig. 5. The absorption spectra exhibit several peaks superimposed on a stepwise curve. The peaks correspond to HH and LH excitons at \(C1-H1\), \(C1-L1\), \(C2-H2\), and \(C2-L2\) transitions. The exciton resonance dominates the band edge peaks and results in a sharper absorption edge. The peaks at \(C1-H1\) and \(C1-L1\) are of higher magnitude than others because of a strong quantum confinement. The absorption coefficient of the interdiffused MQW case are shown in Figs. 5(b) and 5(c). With increasing diffusion length the HH exciton related peak, which determines the absorption edge of the structure, together with the whole spectrum, shifts to shorter wavelengths. The TM polarization absorption spectrum is shown in Fig. 6. It is noted that only two LH confined subbands are supported by this MQW structure and since only LH states contribute to TM polarization absorption, a single absorption peak results for the fundamental edge. The effects of interdiffusion to the absorption spectrum of TM polarization is similar to TE polarization, for the whole spectrum shifts to short wavelength when the diffusion length increases.

In comparison with other models for absorption calculation\(^{33}\) and experimental measurement of the absorption spectra,\(^{34}\) the presented spectra agree well with these
results and thus demonstrates the accuracy of the model. The obtained spectra provide reliable information on the optical properties of the MQW structures.

V. CONCLUSION

A model is presented which is based on a semianalytical and semiempirical method for the index of refraction of interdiffused AlGaAs/GaAs QW, at wavelengths ranging from 0.6 to 1.6 μm. The result is in excellent agreement with experimental measurements. The results show that for the refractive index at above band-edge wavelengths, the spectrum shifts to shorter wavelengths as the extent of interdiffusion increases, which results in a decreasing refractive index. The refractive index difference provides a positive refractive index step with respect to the less interdiffused structures. The properties of this index step finds application in producing a waveguide structure by a laterally differential interdiffusion manner.

In the birefringence analysis of interdiffused AlGaAs/GaAs QWs the results show that at long wavelengths the as-grown quantum well birefringence is small and positive. As interdiffusion proceeds it reduces to zero and becomes very slightly negative before becoming zero again. For the range of wavelengths between the quantum well and barrier band edges, a negative birefringence is located at the longer wavelength side which is followed by a positive value at shorter wavelengths. Both of these birefringence reduce with increasing interdiffusion.

The absorption spectra demonstrate good agreement with the experimental measurements. They exhibit well-defined excitonic peaks, for confined eigenstates up to the third subbands, which shift to shorter wavelengths with interdiffusion and remain well resolved for L_d up to 40 Å.

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20 It should be noted here that the definition of L_d varies in the literature; for instance, some authors define L_d as 2(Dt)^1/2, i.e., L_d^2 variance and L_d/√2 standard deviation.